

<b>Notice of References Cited</b>	Application/Control No. 10/556,916		Applicant(s)/Patent Under Reexamination AKIMOTO ET AL.	
	Examiner MICHAEL VANCHY JR		Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,913,861 B2	07-2005	Shishido et al.	430/30
*	B	US-6,952,492 B2	10-2005	Tanaka et al.	382/149
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*	N	EP 643293 A1	03-1995	European Patent	INOUE et al.	
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#### NON-PATENT DOCUMENTS

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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